

PXP9R1-30QLJ-VB Datasheet

P-Channel 30 V (D-S) MOSFET

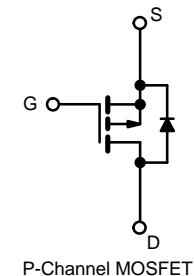
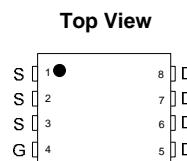
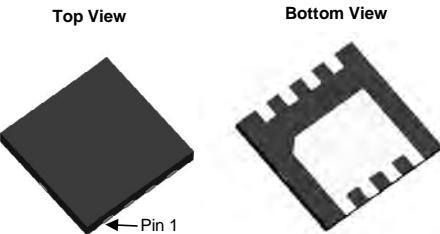
V_{DS}	-30	V
$R_{DS(on),typ}$	$V_{GS}=10V$	11 mΩ
$R_{DS(on),typ}$	$V_{GS}=4.5V$	18 mΩ
I_D	-45 A	

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- Low Thermal Resistance Power Package with Small Size and Low 1.07 mm Profile
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



DFN 3x3 EP



APPLICATIONS

- Load Switch
- Adaptor Switch
- Notebook PC

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$, unless otherwise noted)			
Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	- 30	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current ($T_J = 150^\circ C$)	$T_C = 25^\circ C$	- 45	A
	$T_C = 70^\circ C$	- 30	
	$T_A = 25^\circ C$	- 14.4 ^{a, b}	
	$T_A = 70^\circ C$	- 11.5 ^{a, b}	
Pulsed Drain Current	I_{DM}	- 60	A
Continuous Source-Drain Diode Current	$T_C = 25^\circ C$	- 35 ^e	
	$T_A = 25^\circ C$	- 3.2 ^{a, b}	
Avalanche Current	I_{AS}	- 25	mJ
Single-Pulse Avalanche Energy	E_{AS}	31.25	
Maximum Power Dissipation	$T_C = 25^\circ C$	52	W
	$T_C = 70^\circ C$	43	
	$T_A = 25^\circ C$	3.8 ^{a, b}	
	$T_A = 70^\circ C$	2.4 ^{a, b}	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 50 to 150	°C
Soldering Recommendations (Peak Temperature) ^{c, d}		260	

Notes:

- Surface mounted on 1" x 1" FR4 board.
- $t = 10$ s.
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Package limited.
- Based on $T_C = 25^\circ C$

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, b}	$t \leq 10 \text{ s}$	R_{thJA}	26	33	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	1.9	2.4	

Notes:

a. Surface mounted on 1" x 1" FR4 board.
b. Maximum under Steady State conditions is 81 °C/W.

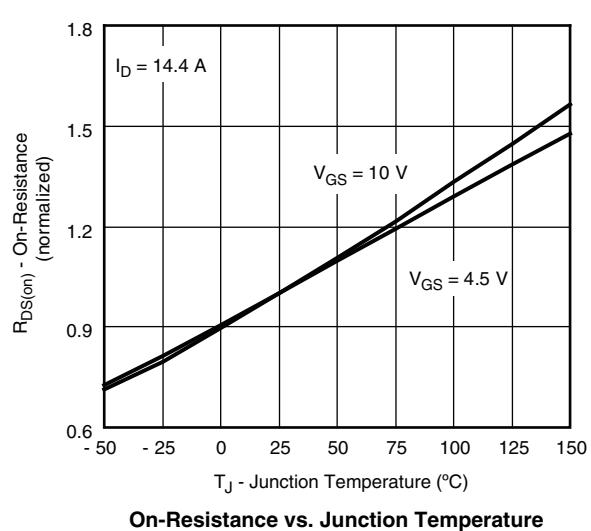
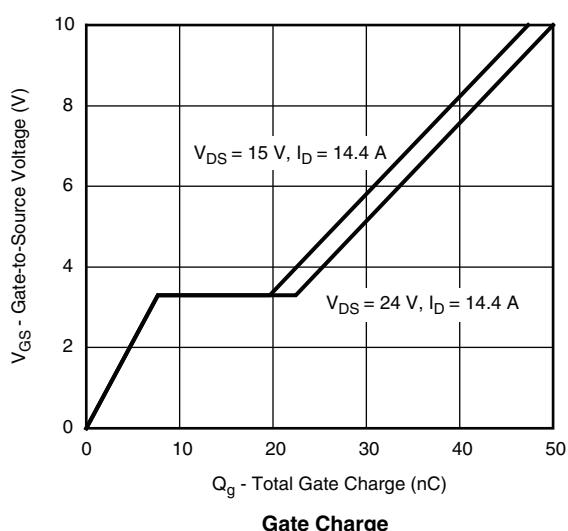
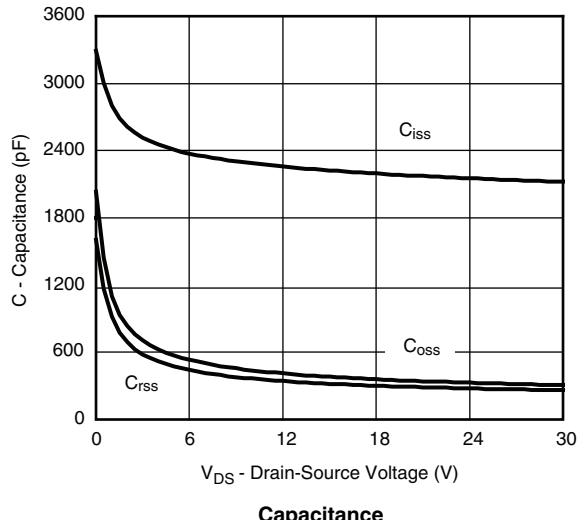
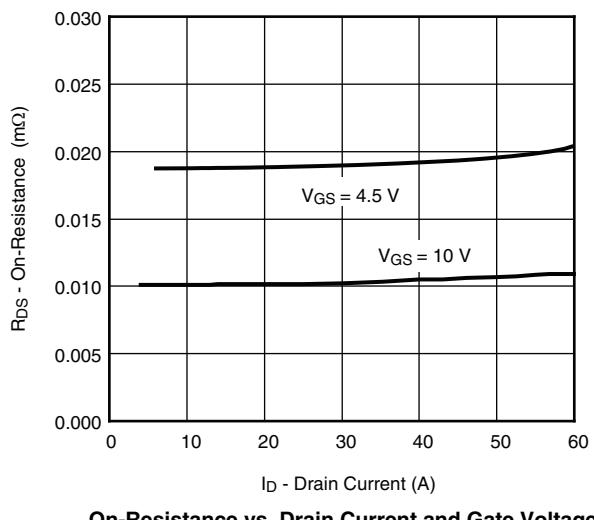
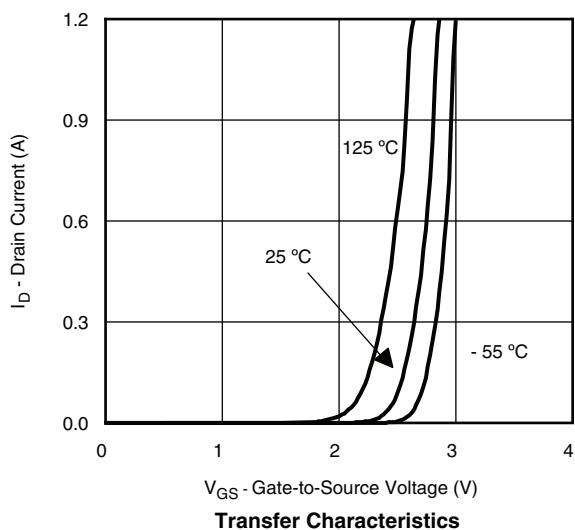
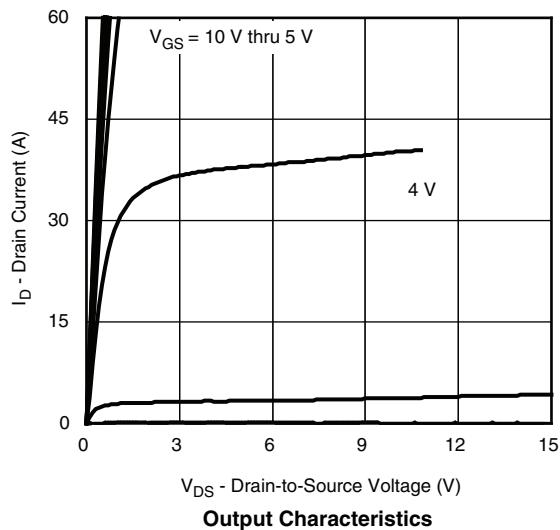
SPECIFICATIONS ($T_J = 25 \text{ °C}$, unless otherwise noted)

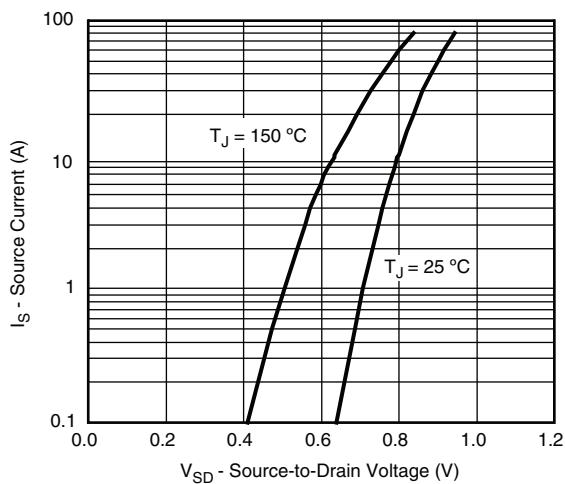
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-30			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = -250 \mu\text{A}$		-20		mV/°C
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			5		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$	-1.5		-2.8	V
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μA
		$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55 \text{ °C}$			-10	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \leq -5 \text{ V}, V_{GS} = -10 \text{ V}$	-20			A
Drain-Source On-State Resistance ^a	$R_{DS(on)}$	$V_{GS} = -10 \text{ V}, I_D = -14.4 \text{ A}$		11		mΩ
		$V_{GS} = -4.5 \text{ V}, I_D = -11.5 \text{ A}$		18		
Forward Transconductance ^a	g_{fs}	$V_{DS} = -15 \text{ V}, I_D = -14.4 \text{ A}$		37		S
Dynamic^b						
Input Capacitance	C_{iss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		2000		pF
Output Capacitance	C_{oss}			385		
Reverse Transfer Capacitance	C_{rss}			322		
Total Gate Charge	Q_g	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -14.4 \text{ A}$			15	nC
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -14.4 \text{ A}$			14	
Gate-Drain Charge	Q_{gd}				7	
Gate Resistance	R_g		$f = 1 \text{ MHz}$	0.4	1.8	3.6
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -15 \text{ V}, R_L = 1.5 \Omega$ $I_D \equiv -10 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		50	75	ns
Rise Time	t_r			43	65	
Turn-Off Delay Time	$t_{d(off)}$			30	45	
Fall Time	t_f			14	21	
Turn-On Delay Time	$t_{d(on)}$			14	21	
Rise Time	t_r	$V_{DD} = -15 \text{ V}, R_L = 1.5 \Omega$ $I_D \equiv -10 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		9	18	ns
Turn-Off Delay Time	$t_{d(off)}$			36	54	
Fall Time	t_f			10	20	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25 \text{ °C}$			-35 ^e	A
Pulse Diode Forward Current ^a	I_{SM}				-60	
Body Diode Voltage	V_{SD}	$I_F = -10 \text{ A}$		-0.8	-1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = -10 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, T_J = 25 \text{ °C}$		31	47	ns
Body Diode Reverse Recovery Charge	Q_{rr}			30	45	nC
Reverse Recovery Fall Time	t_a			15		ns
Reverse Recovery Rise Time	t_b			16		

Notes:

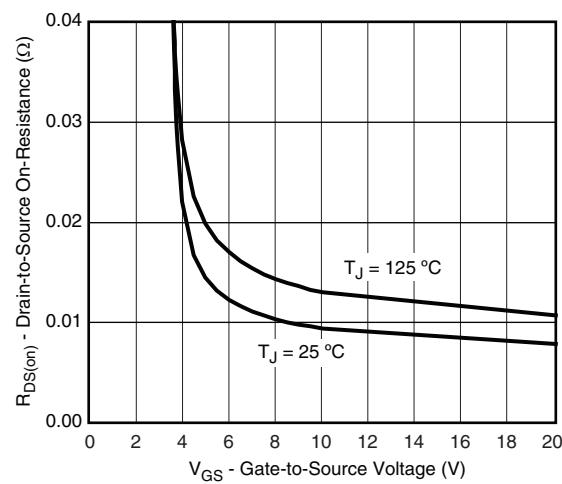
a. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2 \%$.
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

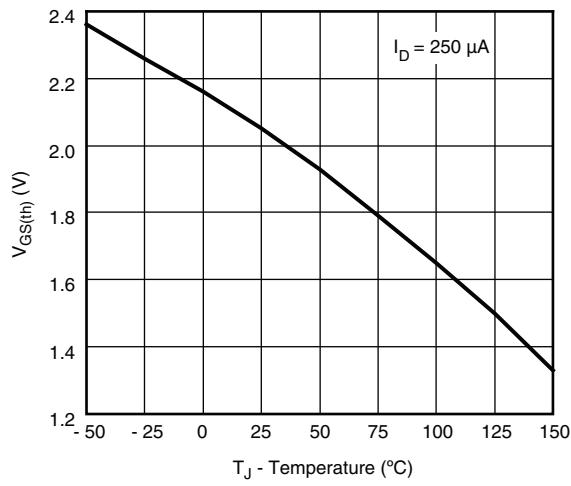
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)


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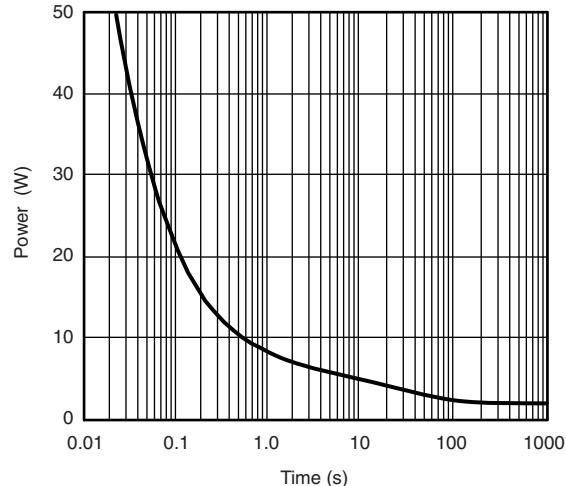
Source-Drain Diode Forward Voltage



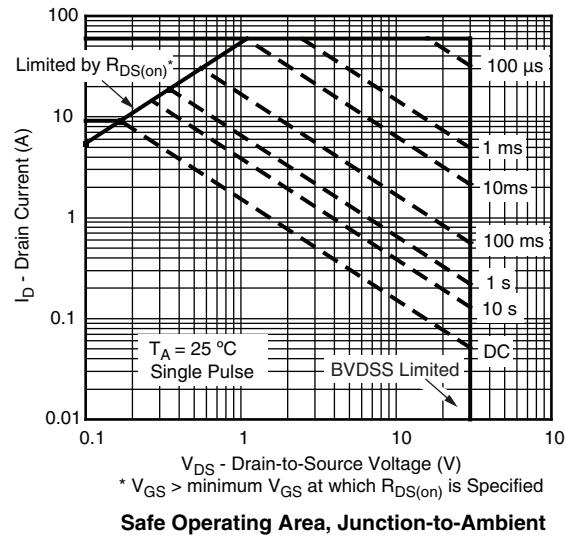
On-Resistance vs. Gate-to-Source Voltage



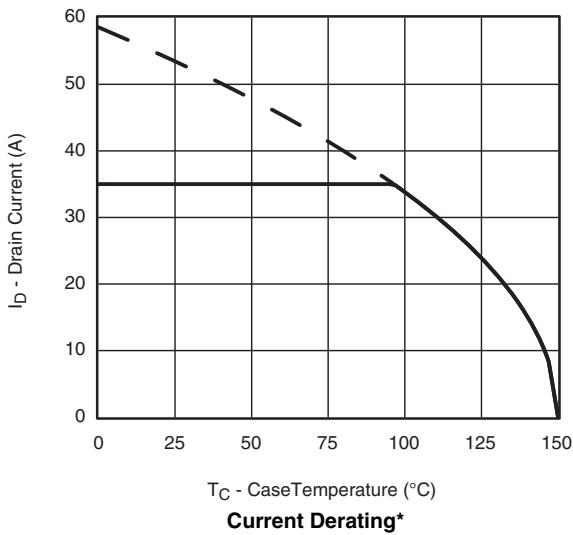
Threshold Voltage



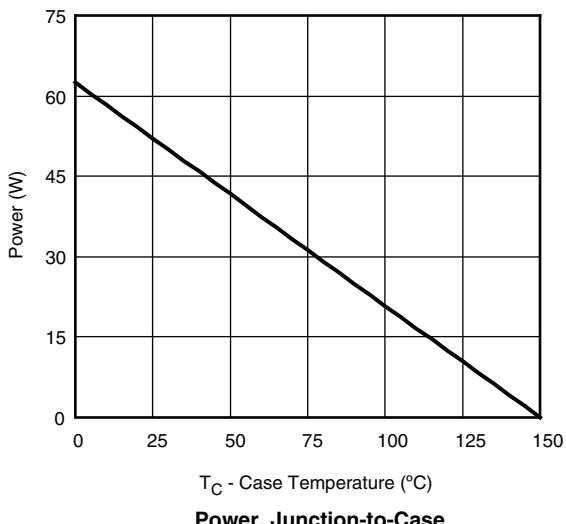
Single Pulse Power, Junction-to-Ambient



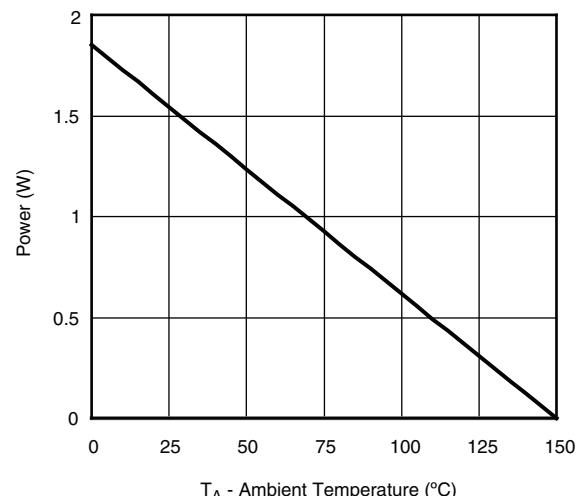
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)
 T_C - Case Temperature (°C)

Current Derating*

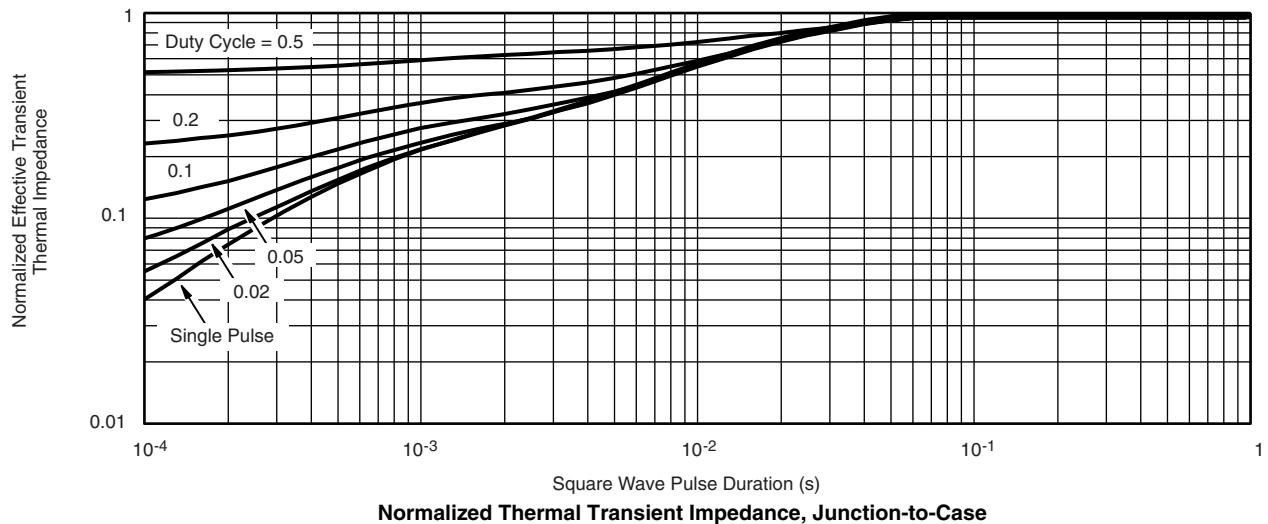
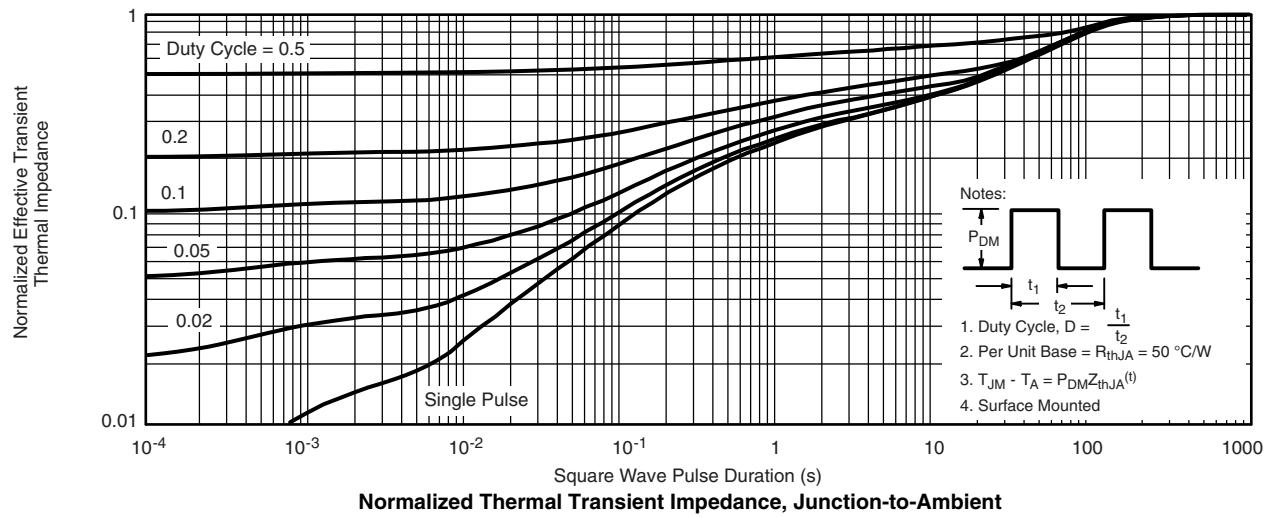
 T_C - Case Temperature (°C)

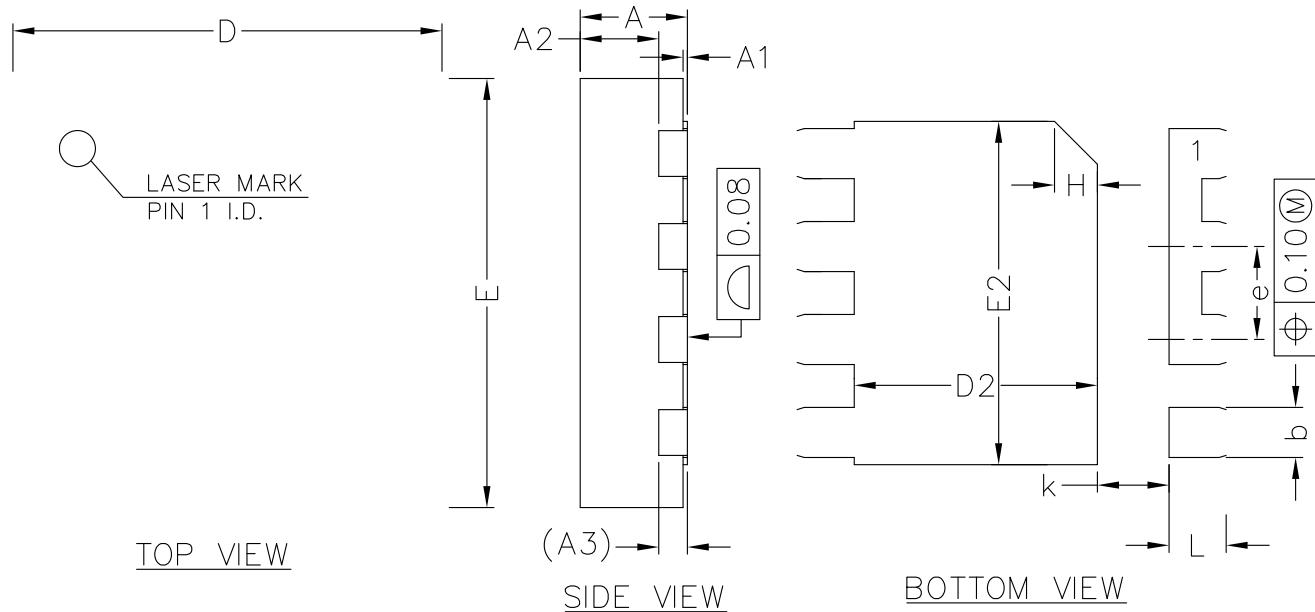
Power, Junction-to-Case

 T_A - Ambient Temperature (°C)

Power, Junction-to-Ambient

* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)




SIDE VIEW

COMMON DIMENSIONS
 (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A2	0.50	0.55	0.60
A3	0.20REF		
b	0.30	0.35	0.40
D	2.90	3.00	3.10
E	2.90	3.00	3.10
D2	1.60	1.70	1.80
E2	2.30	2.40	2.50
e	0.55	0.65	0.75
K	0.40	0.50	0.60
L	0.35	0.40	0.45

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